

<b>Notice of References Cited</b>	Application/Control No. 10/801,697	Applicant(s)/Patent Under Reexamination ISHII ET AL.
	Examiner David E. Graybill	Art Unit 2822

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,763,188 A	08-1988	Johnson, Thomas	257/777
*	B	US-5,319,522 A	06-1994	Mehta, Rajendra M.	361/748
*	C	US-6,059,382 A	05-2000	Schoettl, Johannes	303/119.3
*	D	US-2001/0003373 A1	06-2001	AKRAM, SALMAN	257/678
*	E	US-2001/0005048 A1	06-2001	Krause et al.	257/691
*	F	US-2001/0022404 A1	09-2001	Yamamoto et al.	257/783
*	G	US-2002/0126951 A1	09-2002	Sutherland et al.	385/24
*	H	US-6,548,895 B1	04-2003	Benavides et al.	257/712
*	I	US-2003/0137032 A1	07-2003	Abbott, Donald C.	257/666
*	J	US-6,695,748 B2	02-2004	Kopec et al.	477/130
*	K	US-2004/0045614 A1	03-2004	Subramanian et al.	137/884
*	L	US-6,715,510 B2	04-2004	Herbert, David E.	137/884
*	M	US-6,739,042 B2	05-2004	Thorun, Michael D.	29/832

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 06216532 A	08-1994	Japan	SEGAWA, MASAO	
	O	JP 61030093 A	02-1986	Japan		
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

<b>Notice of References Cited</b>	Application/Control No.	Applicant(s)/Patent Under Reexamination	
	10/801,697	ISHII ET AL.	
	Examiner	Art Unit	Page 2 of 4
	David E. Graybill	2822	

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,611,372 A	03-1997	Bauer et al.	137/884
*	B	US-5,662,007 A	09-1997	Starker et al.	74/606A
*	C	US-5,692,909 A	12-1997	Gadzinski, Steven A.	439/34
*	D	US-5,733,598 A	03-1998	Sera et al.	427/97.2
*	E	US-5,823,070 A	10-1998	Taniguchi et al.	74/606R
*	F	US-6,049,975 A	04-2000	Clayton, James E.	29/832
*	G	US-6,056,908 A	05-2000	Petrosky et al.	264/272.14
*	H	US-6,155,119 A	12-2000	Normann et al.	73/756
*	I	US-2002/0073538 A1	06-2002	Thorun, Michael D.	29/832
*	J	US-2002/0088304 A1	07-2002	Thorun et al.	74/606.00R
*	K	US-2002/0111730 A1	08-2002	Thorun et al.	701/51
*	L	US-6,530,856 B1	03-2003	Kakiage, Kenji	475/123
*	M	US-6,612,202 B2	09-2003	Thorun et al.	74/606R

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

<b>Notice of References Cited</b>		Application/Control No. 10/801,697	Applicant(s)/Patent Under Reexamination ISHII ET AL.	
		Examiner David E. Graybill	Art Unit 2822	Page 3 of 4

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,218,516 A	06-1993	Collins et al.	361/721
*	B	US-5,276,584 A	01-1994	Collins et al.	361/718
*	C	US-5,305,663 A	04-1994	Leonard et al.	475/123
*	D	US-5,831,788 A	11-1998	Hofland, Jonathan C.	360/97.01
*	E	US-5,855,229 A	01-1999	Gluf, Jr., Carl G.	137/884
*	F	US-5,927,240 A	07-1999	Maxon, Eric A.	123/179.3
*	G	US-6,023,098 A	02-2000	Higashiguchi et al.	257/712
*	H	US-6,164,160 A	12-2000	Nassar, Roy S.	74/606R
*	I	US-6,160,708 A	12-2000	Loibl et al.	361/704
*	J	US-2003/0168043 A1	09-2003	Sakurai et al.	123/399
*	K	US-2003/0226527 A1	12-2003	Herbert, David E.	123/90.13
*	L	US-2004/0118466 A1	06-2004	Ford et al.	137/884
*	M	US-7,047,939 B2	05-2006	Sakurai et al.	123/399

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

<b>Notice of References Cited</b>		Application/Control No. 10/801,697	Applicant(s)/Patent Under Reexamination ISHII ET AL.	
		Examiner David E. Graybill	Art Unit 2822	Page 4 of 4

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,266,746 A	11-1993	Nishihara et al.	174/254
*	B	US-2002/0032093 A1	03-2002	Kopec et al.	475/114
*	C	US-6,885,522 B1	04-2005	Kira et al.	360/244.1
*	D	US-2006/0038284 A1	02-2006	Brandenburg et al.	257/714
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.